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[Embedded - Microcontrollers - Application Specific](#) represents a category of microcontrollers designed with unique features and capabilities tailored to specific application needs. Unlike general-purpose microcontrollers, application-specific microcontrollers are optimized for particular tasks, offering enhanced performance, efficiency, and functionality to meet the demands of specialized applications.

What Are [Embedded - Microcontrollers - Application Specific](#)?

Application specific microcontrollers are engineered to

Details

Product Status	Obsolete
Applications	Capacitive Sensing
Core Processor	M8C
Program Memory Type	FLASH (16kB)
Controller Series	CY8C20xx7/S
RAM Size	2K x 8
Interface	I ² C, SPI
Number of I/O	13
Voltage - Supply	1.71V ~ 5.5V
Operating Temperature	-40°C ~ 85°C
Mounting Type	Surface Mount
Package / Case	16-SOIC (0.154", 3.90mm Width)
Supplier Device Package	16-SOIC
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/cy8c20247-24sxi

PSoC® Functional Overview

The PSoC family consists of many devices with on-chip controllers. These devices are designed to replace multiple traditional MCU-based system components with one low-cost single-chip programmable component. A PSoC device includes configurable blocks of analog and digital logic, and programmable interconnect. This architecture makes it possible for you to create customized peripheral configurations, to match the requirements of each individual application. Additionally, a fast central processing unit (CPU), flash program memory, SRAM data memory, and configurable I/O are included in a range of convenient pinouts.

The architecture for this device family, as shown in the “Logic Block Diagram” on page 2, consists of three main areas:

- The core
- CapSense analog system
- System resources

A common, versatile bus allows connection between I/O and the analog system.

Each CY8C20x37/47/67/S PSoC device includes a dedicated CapSense block that provides sensing and scanning control circuitry for capacitive sensing applications. Depending on the PSoC package, up to 34 GPIOs are also included. The GPIOs provide access to the MCU and analog mux.

PSoC Core

The PSoC core is a powerful engine that supports a rich instruction set. It encompasses SRAM for data storage, an interrupt controller, sleep and watchdog timers, and IMO and I/O. The CPU core, called the M8C, is a powerful processor with speeds up to 24 MHz. The M8C is a 4-million instructions per second (MIPS), 8-bit Harvard-architecture microprocessor.

CapSense System

The analog system contains the capacitive sensing hardware. Several hardware algorithms are supported. This hardware performs capacitive sensing and scanning without requiring external components. The analog system is composed of the CapSense PSoC block and an internal 1 V or 1.2 V analog reference, which together support capacitive sensing of up to 31 inputs^[2]. Capacitive sensing is configurable on each GPIO pin. Scanning of enabled CapSense pins is completed quickly and easily across multiple ports.

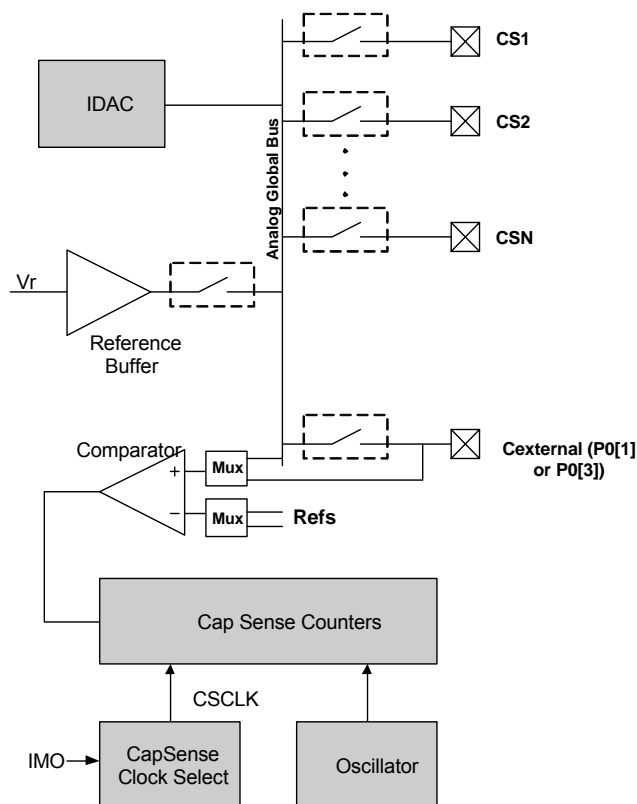
SmartSense™ Auto-tuning

SmartSense auto-tuning is an innovative solution from Cypress that removes manual tuning of CapSense applications. This solution is easy to use and provides robust noise immunity. It is the only auto-tuning solution that establishes, monitors, and maintains all required tuning parameters of each sensor during run time. SmartSense auto-tuning allows engineers to go from prototyping to mass production without retuning for manufacturing variations in PCB and/or overlay material properties.

Note

2. 34 GPIOs = 31 pins for capacitive sensing + 2 pins for I²C + 1 pin for modulator capacitor.

Figure 1. CapSense System Block Diagram



Analog Multiplexer System

The analog mux bus can connect to every GPIO pin. Pins are connected to the bus individually or in any combination. The bus also connects to the analog system for analysis with the CapSense block comparator.

Switch-control logic enables selected pins to precharge continuously under hardware control. This enables capacitive measurement for applications such as touch sensing. Other multiplexer applications include:

- Complex capacitive sensing interfaces, such as sliders and touchpads.
- Chip-wide mux that allows analog input from any I/O pin.
- Crosspoint connection between any I/O pin combinations.

Designing with PSoC Designer

The PSoC development process can be summarized in the following four steps:

1. Select [User Modules](#)
2. Configure User Modules
3. Organize and Connect
4. Generate and Verify

Select Components

PSoC Designer provides a library of pre-built, pre-tested hardware peripheral components called “user modules”. User modules make selecting and implementing peripheral devices, both analog and digital, simple.

Configure Components

Each of the User Modules you select establishes the basic register settings that implement the selected function. They also provide parameters and properties that allow you to tailor their precise configuration to your particular application. The user module parameters permit you to establish the pulse width and duty cycle. Configure the parameters and properties to correspond to your chosen application. Enter values directly or by selecting values from drop-down menus. All the user modules are documented in datasheets that may be viewed directly in PSoC Designer or on the Cypress website. These [user module datasheets](#) explain the internal operation of the User Module and provide performance specifications. Each datasheet describes the use of each user module parameter, and other information you may need to successfully implement your design.

Organize and Connect

You build signal chains at the chip level by interconnecting user modules to each other and the I/O pins. You perform the selection, configuration, and routing so that you have complete control over all on-chip resources.

Generate, Verify, and Debug

When you are ready to test the hardware configuration or move on to developing code for the project, you perform the “Generate Configuration Files” step. This causes PSoC Designer to generate source code that automatically configures the device to your specification and provides the software for the system. The generated code provides application programming interfaces (APIs) with high-level functions to control and respond to hardware events at run time and interrupt service routines that you can adapt as needed.

A complete code development environment allows you to develop and customize your applications in C, assembly language, or both.

Pinouts

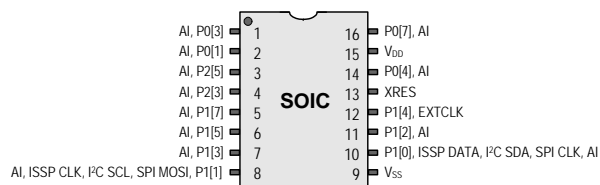
The CY8C20x37/47/67/S PSoC device is available in a variety of packages, which are listed and illustrated in the following tables. Every port pin (labeled with a “P”) is capable of digital I/O and connection to the common analog bus. However, V_{SS} , V_{DD} , and XRES are not capable of digital I/O.

16-pin SOIC (10 Sensing Inputs)

Table 1. Pin Definitions – CY8C20237-24SXI, CY8C20247/S-24SXI ^[3]

Pin No.	Type		Name	Description
	Digital	Analog		
1	I/O	I	P0[3]	Integrating Input
2	I/O	I	P0[1]	Integrating Input
3	I/O	I	P2[5]	Crystal output (XOut)
4	I/O	I	P2[3]	Crystal input (XIn)
5	I/O	I	P1[7]	I2C SCL, SPI SS
6	I/O	I	P1[5]	I2C SDA, SPI MISO
7	I/O	I	P1[3]	
8	I/O	I	P1[1]	ISSP CLK ^[4] , I2C SCL, SPI MOSI
9	Power		V_{SS}	Ground connection ^[7]
10	I/O	I	P1[0]	ISSP DATA ^[4] , I2C SDA, SPI CLK ^[5]
11	I/O	I	P1[2]	Driven Shield Output (optional)
12	I/O	I	P1[4]	Optional external clock (EXTCLK)
13	INPUT		XRES	Active high external reset with internal pull-down ^[6]
14	I/O	I	P0[4]	
15	Power		V_{DD}	Supply voltage
16	I/O	I	P0[7]	

Figure 2. CY8C20237-24SXI, CY8C20247/S-24SXI Device



LEGEND A = Analog, I = Input, O = Output, OH = 5 mA High Output Drive, R = Regulated Output.

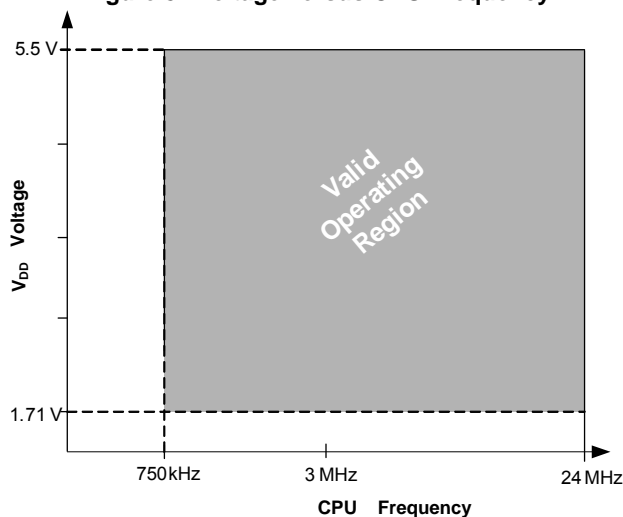
Notes

- 13 GPIOs = 10 pins for capacitive sensing+2 pins for I²C + 1 pin for modulator capacitor.
- On power-up, the SDA(P1[0]) drives a strong high for 256 sleep clock cycles and drives resistive low for the next 256 sleep clock cycles. The SCL(P1[1]) line drives resistive low for 512 sleep clock cycles and both the pins transition to high impedance state. On reset, after XRES de-asserts, the SDA and the SCL lines drive resistive low for 8 sleep clock cycles and transition to high impedance state. Hence, during power-up or reset event, P1[1] and P1[0] may disturb the I2C bus. Use alternate pins if you encounter issues.
- Alternate SPI clock.
- The internal pull down is 5KOhm.
- All VSS pins should be brought out to one common GND plane.

Electrical Specifications

This section presents the DC and AC electrical specifications of the CY8C20x37/47/67/S PSoC devices. For the latest electrical specifications, confirm that you have the most recent datasheet by visiting the web at <http://www.cypress.com/psoc>.

Figure 8. Voltage versus CPU Frequency



Absolute Maximum Ratings

Exceeding maximum ratings may shorten the useful life of the device. User guidelines are not tested.

Table 7. Absolute Maximum Ratings

Symbol	Description	Conditions	Min	Typ	Max	Units
T _{STG}	Storage temperature	Higher storage temperatures reduce data retention time. Recommended Storage Temperature is +25 °C ± 25 °C. Extended duration storage temperatures above 85 °C degrades reliability.	-55	+25	+125	°C
V _{DD}	Supply voltage relative to V _{SS}	—	-0.5	—	+6.0	V
V _{IO}	DC input voltage	—	V _{SS} - 0.5	—	V _{DD} + 0.5	V
V _{IOZ}	DC voltage applied to tristate	—	V _{SS} - 0.5	—	V _{DD} + 0.5	V
I _{MIO}	Maximum current into any port pin	—	-25	—	+50	mA
ESD	Electro static discharge voltage	Human body model ESD	2000	—	—	V
LU	Latch up current	In accordance with JESD78 standard	—	—	200	mA

Operating Temperature

Table 8. Operating Temperature

Symbol	Description	Conditions	Min	Typ	Max	Units
T _A	Ambient temperature	—	-40	—	+85	°C
T _C	Commercial temperature range	—	0	—	70	°C
T _J	Operational die temperature	The temperature rise from ambient to junction is package specific. See the Thermal Impedances on page 30 . The user must limit the power consumption to comply with this requirement.	-40	—	+100	°C

DC Chip-Level Specifications

Table 9 lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 9. DC Chip-Level Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
V_{DD} [37, 38, 39]	Supply voltage	See Table 14 on page 17.	1.71	–	5.50	V
I_{DD24}	Supply current, IMO = 24 MHz	Conditions are $V_{DD} \leq 3.0$ V, $T_A = 25$ °C, CPU = 24 MHz. CapSense running at 12 MHz, no I/O sourcing current	–	2.88	4.00	mA
I_{DD12}	Supply current, IMO = 12 MHz	Conditions are $V_{DD} \leq 3.0$ V, $T_A = 25$ °C, CPU = 12 MHz. CapSense running at 12 MHz, no I/O sourcing current	–	1.71	2.60	mA
I_{DD6}	Supply current, IMO = 6 MHz	Conditions are $V_{DD} \leq 3.0$ V, $T_A = 25$ °C, CPU = 6 MHz. CapSense running at 6 MHz, no I/O sourcing current	–	1.16	1.80	mA
I_{SB0} [40, 41, 42, 43]	Deep sleep current	$V_{DD} \leq 3.0$ V, $T_A = 25$ °C, I/O regulator turned off	–	0.10	1.1	μA
I_{SB1} [40, 41, 42, 43]	Standby current with POR, LVD and sleep timer	$V_{DD} \leq 3.0$ V, $T_A = 25$ °C, I/O regulator turned off	–	1.07	1.50	μA
I_{SBI2C} [40, 41, 42, 43]	Standby current with I ² C enabled	Conditions are $V_{DD} = 3.3$ V, $T_A = 25$ °C and CPU = 24 MHz	–	1.64	–	μA

Notes

37. When V_{DD} remains in the range from 1.71 V to 1.9 V for more than 50 μs, the slew rate when moving from the 1.71 V to 1.9 V range to greater than 2 V must be slower than 1 V/500 μs to avoid triggering POR. The only other restriction on slew rates for any other voltage range or transition is the SR_{POWER_UP} parameter.
38. If powering down in standby sleep mode, to properly detect and recover from a V_{DD} brown out condition any of the following actions must be taken:
 - a. Bring the device out of sleep before powering down.
 - b. Assume that V_{DD} falls below 100 mV before powering back up.
 - c. Set the No Buzz bit in the OSC_CR0 register to keep the voltage monitoring circuit powered during sleep.
 - d. Increase the buzz rate to assure that the falling edge of V_{DD} is captured. The rate is configured through the PSSDC bits in the SLP_CFG register. For the referenced registers, refer to the [Technical Reference Manual](#). In deep sleep/standby sleep mode, additional low power voltage monitoring circuitry allows V_{DD} brown out conditions to be detected and resets the device when V_{DD} goes lower than 1.1 V at edge rates slower than 1 V/ms.
39. For proper CapSense block functionality, if the drop in V_{DD} exceeds 5% of the base V_{DD} , the rate at which V_{DD} drops should not exceed 200 mV/s. Base V_{DD} can be between 1.8 V and 5.5 V.
40. **Errata:** When programmable timer 0 is used in “one-shot” mode by setting bit 1 of register 0,80h (PT0_CFG), and the timer interrupt is used to wake the device from sleep, the interrupt service routine (ISR) may be executed twice. For more information, see the [“Errata”](#) on page 37.
41. **Errata:** When in sleep mode, if a GPIO interrupt happens simultaneously with a Timer0 or Sleep Timer interrupt, the GPIO interrupt may be missed, and the corresponding GPIO ISR not run. For more information, see the [“Errata”](#) on page 37.
42. **Errata:** If an interrupt is posted a short time (within 2.5 CPU cycles) before firmware commands the device to sleep, the interrupt will be missed. For more information, see the [“Errata”](#) on page 37.
43. **Errata:** Device wakes up from sleep when an analog interrupt is trigger. For more information, see the [“Errata”](#) on page 37.

Table 12. 1.71 V to 2.4 V DC GPIO Specifications (continued)

Symbol	Description	Conditions	Min	Typ	Max	Units
V_{OL}	Low output voltage	$I_{OL} = 5$ mA, maximum of 20 mA sink current on even port pins (for example, P0[2] and P1[4]) and 30 mA sink current on odd port pins (for example, P0[3] and P1[5])	–	–	0.40	V
V_{IL}	Input low voltage	–	–	–	$0.30 \times V_{DD}$	V
V_{IH}	Input high voltage	–	$0.65 \times V_{DD}$	–	–	V
V_H	Input hysteresis voltage	–	–	80	–	mV
I_{IL}	Input leakage (absolute value)	–	–	1	1000	nA
C_{PIN}	Capacitive load on pins	Package and pin dependent temp = 25 °C	0.50	1.70	7	pF

Table 13. GPIO Current Sink and Source Specifications

Supply Voltage	Mode	Port 0/1 per I/O (max)	Port 2/3/4 per I/O (max)	Total Current Even Pins (max)	Total Current Odd Pins (max)	Units
1.71–2.4	Sink	5	5	20	30	mA
	Source	2	0.5	$10^{[45]}$		mA
2.4–3.0	Sink	10	10	30	30	mA
	Source	2	0.2	$10^{[45]}$		mA
3.0–5.0	Sink	25	25	60	60	mA
	Source	5	1	$20^{[45]}$		mA

DC Analog Mux Bus Specifications

Table 14 lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 14. DC Analog Mux Bus Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
R_{SW}	Switch resistance to common analog bus	–	–	–	800	Ω
R_{GND}	Resistance of initialization switch to V_{SS}	–	–	–	800	Ω

The maximum pin voltage for measuring R_{SW} and R_{GND} is 1.8 V

DC Low Power Comparator Specifications

Table 15 lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 15. DC Comparator Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
V_{LPC}	Low power comparator (LPC) common mode	Maximum voltage limited to V_{DD}	0.2	–	1.8	V
I_{LPC}	LPC supply current	–	–	10	80	μ A
V_{OSLPC}	LPC voltage offset	–	–	2.5	30	mV

Note

45. Total current (odd + even ports)

Comparator User Module Electrical Specifications

Table 16 lists the guaranteed maximum and minimum specifications. Unless stated otherwise, the specifications are for the entire device voltage and temperature operating range: $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$, $1.71\text{ V} \leq V_{DD} \leq 5.5\text{ V}$.

Table 16. Comparator User Module Electrical Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
T_{COMP}	Comparator response time	50 mV overdrive	–	70	100	ns
Offset	–	Valid from 0.2 V to 1.5 V	–	2.5	30	mV
Current	–	Average DC current, 50 mV overdrive	–	20	80	μA
PSRR	Supply voltage > 2 V	Power supply rejection ratio	–	80	–	dB
	Supply voltage < 2 V	Power supply rejection ratio	–	40	–	dB
Input range	–	–	0.2		1.5	V

ADC Electrical Specifications

Table 17. ADC User Module Electrical Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
Input						
V_{IN}	Input voltage range	–	0	–	V_{REFADC}	V
C_{IIN}	Input capacitance	–	–	–	5	pF
R_{IN}	Input resistance	Equivalent switched cap input resistance for 8-, 9-, or 10-bit resolution	$1/(500\text{fF} \times \text{data clock})$	$1/(400\text{fF} \times \text{data clock})$	$1/(300\text{fF} \times \text{data clock})$	Ω
Reference						
V_{REFADC}	ADC reference voltage	–	1.14	–	1.26	V
Conversion Rate						
F_{CLK}	Data clock	Source is chip's internal main oscillator. See AC Chip-Level Specifications on page 21 for accuracy	2.25	–	6	MHz
S8	8-bit sample rate	Data clock set to 6 MHz. sample rate = $0.001/(2^{\text{Resolution}}/\text{Data Clock})$	–	23.43	–	ksps
S10	10-bit sample rate	Data clock set to 6 MHz. sample rate = $0.001/(2^{\text{resolution}}/\text{data clock})$	–	5.85	–	ksps
DC Accuracy						
RES	Resolution	Can be set to 8, 9, or 10 bit	8	–	10	bits
DNL	Differential nonlinearity	–	–1	–	+2	LSB
INL	Integral nonlinearity	–	–2	–	+2	LSB
E_{OFFSET}	Offset error	8-bit resolution	0	3.20	19.20	LSB
		10-bit resolution	0	12.80	76.80	LSB
E_{GAIN}	Gain error	For any resolution	–5	–	+5	%FSR
Power						
I_{ADC}	Operating current	–	–	2.10	2.60	mA
PSRR	Power supply rejection ratio	PSRR ($V_{DD} > 3.0\text{ V}$)	–	24	–	dB
		PSRR ($V_{DD} < 3.0\text{ V}$)	–	30	–	dB

DC POR and LVD Specifications

Table 18 lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 18. DC POR and LVD Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
V _{POR0}	1.66 V selected in PSoC Designer	V _{DD} must be greater than or equal to 1.71 V during startup, reset from the XRES pin, or reset from watchdog.	1.61	1.66	1.71	V
V _{POR1}	2.36 V selected in PSoC Designer		–	2.36	2.41	V
V _{POR2}	2.60 V selected in PSoC Designer		–	2.60	2.66	V
V _{POR3}	2.82 V selected in PSoC Designer		–	2.82	2.95	V
V _{LVD0}	2.45 V selected in PSoC Designer	–	2.40	2.45	2.51	V
V _{LVD1}	2.71 V selected in PSoC Designer		2.64 ^[46]	2.71	2.78	V
V _{LVD2}	2.92 V selected in PSoC Designer		2.85 ^[47]	2.92	2.99	V
V _{LVD3}	3.02 V selected in PSoC Designer		2.95 ^[48]	3.02	3.09	V
V _{LVD4}	3.13 V selected in PSoC Designer		3.06	3.13	3.20	V
V _{LVD5}	1.90 V selected in PSoC Designer		1.84	1.90	2.32	V
V _{LVD6}	1.80 V selected in PSoC Designer		1.75 ^[49]	1.80	1.84	V
V _{LVD7}	4.73 V selected in PSoC Designer		4.62	4.73	4.83	V

DC Programming Specifications

Table 19 lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 19. DC Programming Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
V _{DDIWRITE}	Supply voltage for flash write operations	–	1.71	–	5.25	V
I _{DDP}	Supply current during programming or verify	–	–	5	25	mA
V _{ILP}	Input low voltage during programming or verify	See appropriate “DC GPIO Specifications” on page 15	–	–	V _{IL}	V
V _{IHP}	Input high voltage during programming or verify	See appropriate “DC GPIO Specifications” on page 15	V _{IH}	–	–	V
I _{ILP}	Input current when Applying V _{ILP} to P1[0] or P1[1] during programming or verify	Driving internal pull-down resistor	–	–	0.2	mA
I _{IHP}	Input current when applying V _{IHP} to P1[0] or P1[1] during programming or verify	Driving internal pull-down resistor	–	–	1.5	mA
V _{OLP}	Output low voltage during programming or verify	–	–	–	V _{SS} + 0.75	V
V _{OHP}	Output high voltage during programming or verify	See appropriate “DC GPIO Specifications” on page 15. For V _{DD} > 3V use V _{OH4} in Table 10 on page 15.	V _{OH}	–	V _{DD}	V
Flash _{ENPB}	Flash write endurance	Erase/write cycles per block	50,000	–	–	–
Flash _{DR}	Flash data retention	Following maximum Flash write cycles; ambient temperature of 55 °C	20	–	–	Years

Notes

46. Always greater than 50 mV above V_{PPOR1} voltage for falling supply.
 47. Always greater than 50 mV above V_{PPOR2} voltage for falling supply.
 48. Always greater than 50 mV above V_{PPOR3} voltage for falling supply.
 49. Always greater than 50 mV above V_{PPOR0} voltage for falling supply.

DC I²C Specifications

Table 20 list guaranteed maximum and minimum specifications for the voltage and temperature ranges: 3.0 V to 5.5 V and $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$, 2.4 V to 3.0 V and $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$, or 1.71 V to 2.4 V and $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$, respectively. Typical parameters apply to 5 V and 3.3 V at 25°C and are for design guidance only.

Table 20. DC I²C Specifications^[50]

Symbol	Description	Conditions	Min	Typ	Max	Units
V _{ILI2C}	Input low level	$3.1\text{ V} \leq V_{DD} \leq 5.5\text{ V}$	–	–	$0.25 \times V_{DD}$	V
		$2.5\text{ V} \leq V_{DD} \leq 3.0\text{ V}$	–	–	$0.3 \times V_{DD}$	V
		$1.71\text{ V} \leq V_{DD} \leq 2.4\text{ V}$	–	–	$0.3 \times V_{DD}$	V
V _{IHI2C}	Input high level	$1.71\text{ V} \leq V_{DD} \leq 5.5\text{ V}$	$0.65 \times V_{DD}$	–	V_{DD}^{+} $0.7\text{ V}^{[51]}$	V

Shield Driver DC Specifications

Table 21 list guaranteed maximum and minimum specifications for the voltage and temperature ranges: 3.0 V to 5.5 V and $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$, 2.4 V to 3.0 V and $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$, or 1.71 V to 2.4 V and $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$, respectively. Typical parameters apply to 5 V and 3.3 V at 25°C and are for design guidance only.

Table 21. Shield Driver DC Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
V _{Ref}	Reference buffer output	$1.7\text{ V} \leq V_{DD} \leq 5.5\text{ V}$	0.942	–	1.106	V
V _{RefHi}	Reference buffer output	$1.7\text{ V} \leq V_{DD} \leq 5.5\text{ V}$	1.104	–	1.296	V

DC IDAC Specifications

Table 22 lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 22. DC IDAC Specifications (8-bit IDAC)

Symbol	Description	Min	Typ	Max	Units	Notes
IDAC_DNL	Differential nonlinearity	–1	–	1	LSB	–
IDAC_DNL	Integral nonlinearity	–2	–	2	LSB	–
IDAC_Current	Range = 4x	138	–	169	μA	DAC setting = 127 dec
	Range = 8x	138	–	169	μA	DAC setting = 64 dec

Table 23. DC IDAC Specifications (7-bit IDAC)

Symbol	Description	Min	Typ	Max	Units	Notes
IDAC_DNL	Differential nonlinearity	–1	–	1	LSB	–
IDAC_DNL	Integral nonlinearity	–2	–	2	LSB	–
IDAC_Current	Range = 4x	137	–	168	μA	DAC setting = 127 dec
	Range = 8x	138	–	169	μA	DAC setting = 64 dec

Notes

50. Errata: Pull-up resistors on I2C interface cannot be connected to a supply voltage that is more than 0.7 V higher than the CY8C20xx7/S power supply. For more information see item #6 in the "Errata" on page 37.

51. Errata: For more information see item #6 in the "Errata" on page 37.

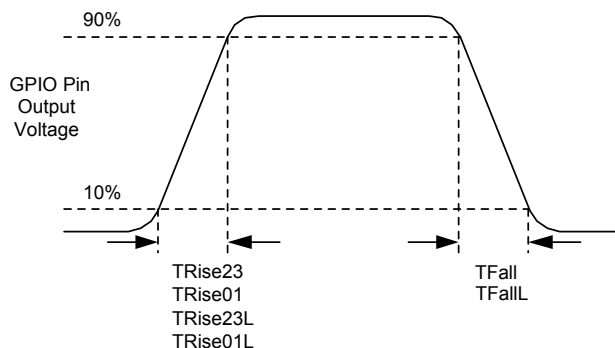
AC General Purpose I/O Specifications

Table 25 lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 25. AC GPIO Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
F_{GPIO}	GPIO operating frequency	Normal strong mode Port 0, 1	0	–	6 MHz for $1.71\text{ V} < V_{DD} < 2.40\text{ V}$	MHz
			0	–	12 MHz for $2.40\text{ V} < V_{DD} < 5.50\text{ V}$	MHz
t_{RISE23}	Rise time, strong mode, Cload = 50 pF Ports 2 or 3	$V_{DD} = 3.0\text{ to }3.6\text{ V}$, 10% to 90%	15	–	80	ns
$t_{RISE23L}$	Rise time, strong mode low supply, Cload = 50 pF, Ports 2 or 3	$V_{DD} = 1.71\text{ to }3.0\text{ V}$, 10% to 90%	15	–	80	ns
t_{RISE01}	Rise time, strong mode, Cload = 50 pF Ports 0 or 1	$V_{DD} = 3.0\text{ to }3.6\text{ V}$, 10% to 90% LDO enabled or disabled	10	–	50	ns
$t_{RISE01L}$	Rise time, strong mode low supply, Cload = 50 pF, Ports 0 or 1	$V_{DD} = 1.71\text{ to }3.0\text{ V}$, 10% to 90% LDO enabled or disabled	10	–	80	ns
t_{FALL}	Fall time, strong mode, Cload = 50 pF all ports	$V_{DD} = 3.0\text{ to }3.6\text{ V}$, 10% to 90%	10	–	50	ns
t_{FALLL}	Fall time, strong mode low supply, Cload = 50 pF, all ports	$V_{DD} = 1.71\text{ to }3.0\text{ V}$, 10% to 90%	10	–	70	ns

Figure 9. GPIO Timing Diagram



AC Comparator Specifications

Table 26 lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 26. AC Low Power Comparator Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
t_{LPC}	Comparator response time, 50 mV overdrive	50 mV overdrive does not include offset voltage.	–	–	100	ns

AC External Clock Specifications

Table 27 lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 27. AC External Clock Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
F_{OSCEXT}	Frequency (external oscillator frequency)	–	0.75	–	25.20	MHz
	High period	–	20.60	–	5300	ns
	Low period	–	20.60	–	–	ns
	Power-up IMO to switch	–	150	–	–	μs

AC Programming Specifications

Figure 10. AC Waveform

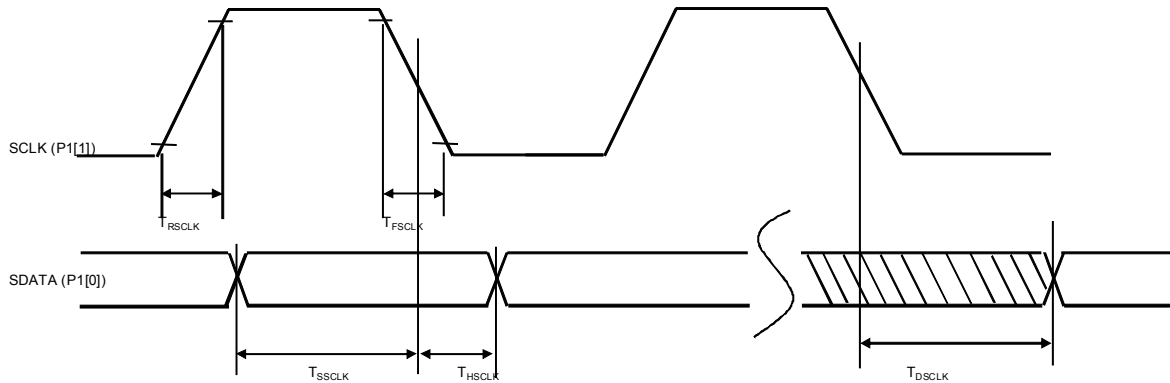


Table 28 lists the guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 28. AC Programming Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
t_{RSCLK}	Rise time of SCLK	—	1	—	20	ns
t_{FSCLK}	Fall time of SCLK	—	1	—	20	ns
t_{SSCLK}	Data setup time to falling edge of SCLK	—	40	—	—	ns
t_{HSCLK}	Data hold time from falling edge of SCLK	—	40	—	—	ns
F_{SCLK}	Frequency of SCLK	—	0	—	8	MHz
t_{ERASEB}	Flash erase time (block)	—	—	—	18	ms
t_{WRITE}	Flash block write time	—	—	—	25	ms
t_{DSCLK}	Data out delay from falling edge of SCLK	$3.6 < V_{DD}$	—	—	60	ns
t_{DSCLK3}	Data out delay from falling edge of SCLK	$3.0 \leq V_{DD} \leq 3.6$	—	—	85	ns
t_{DSCLK2}	Data out delay from falling edge of SCLK	$1.71 \leq V_{DD} \leq 3.0$	—	—	130	ns
t_{XRST3}	External reset pulse width after power-up	Required to enter programming mode when coming out of sleep	300	—	—	μ s
t_{XRES}	XRES pulse length	—	300	—	—	μ s
$t_{VDDWAIT}^{[54]}$	V_{DD} stable to wait-and-poll hold off	—	0.1	—	1	ms
$t_{VDDXRES}^{[54]}$	V_{DD} stable to XRES assertion delay	—	14.27	—	—	ms
t_{POLL}	SDAT high pulse time	—	0.01	—	200	ms
$t_{ACQ}^{[54]}$	“Key window” time after a V_{DD} ramp acquire event, based on 256 ILO clocks.	—	3.20	—	19.60	ms
$t_{XRESINI}^{[54]}$	“Key window” time after an XRES event, based on 8 ILO clocks	—	98	—	615	μ s

Note

54. Valid from 5 to 50 °C. See the spec, [CY8C20X66](#), [CY8C20X46](#), [CY8C20X36](#), [CY7C643XX](#), [CY7C604XX](#), [CY8CTST2XX](#), [CY8CTMG2XX](#), [CY8C20X67](#), [CY8C20X47](#), [CY8C20X37](#), [Programming Spec](#) for more details.

Table 30. SPI Master AC Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
F_{SCLK}	SCLK clock frequency	$V_{DD} \geq 2.4\text{ V}$ $V_{DD} < 2.4\text{ V}$	– –	– –	6 3	MHz MHz
DC	SCLK duty cycle	–	–	50	–	%
t_{SETUP}	MISO to SCLK setup time	$V_{DD} \geq 2.4\text{ V}$ $V_{DD} < 2.4\text{ V}$	60 100	– –	– –	ns ns
t_{HOLD}	SCLK to MISO hold time	–	40	–	–	ns
t_{OUT_VAL}	SCLK to MOSI valid time	–	–	–	40	ns
t_{OUT_H}	MOSI high time	–	40	–	–	ns

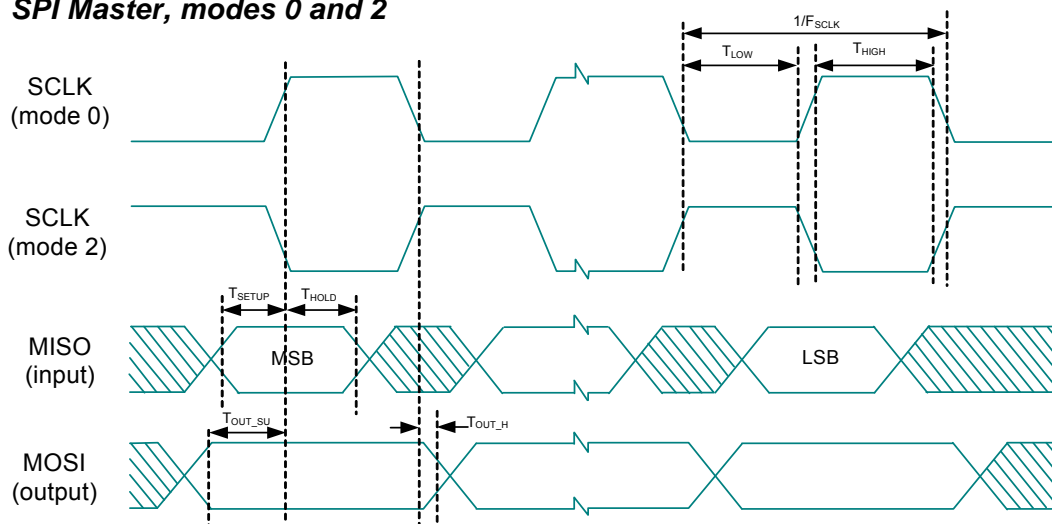
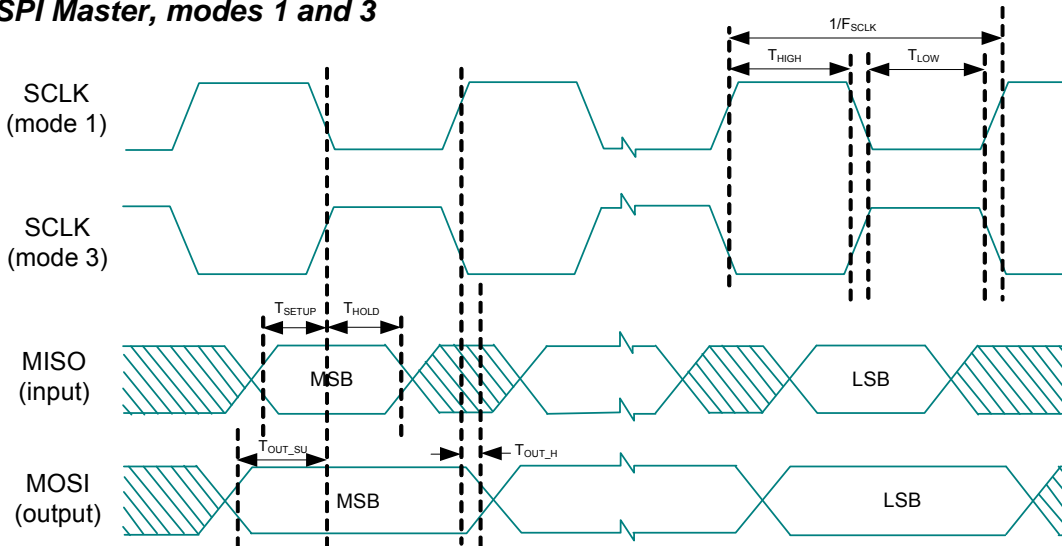
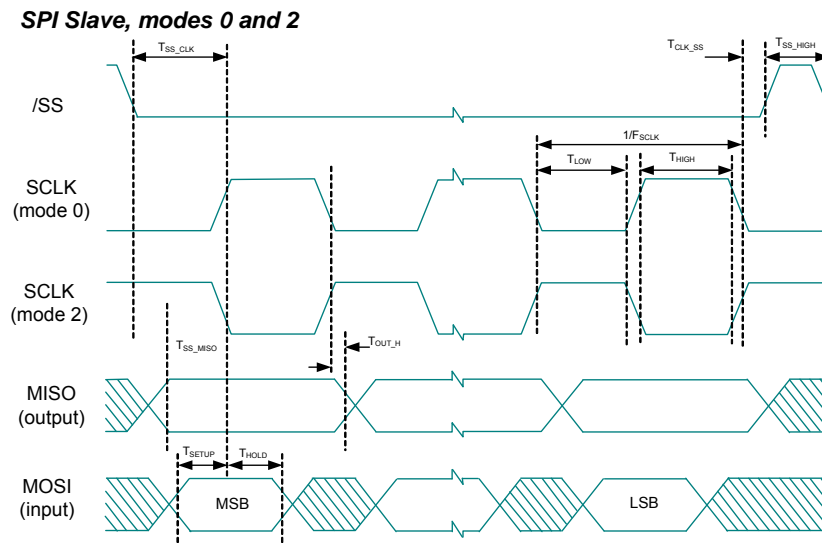
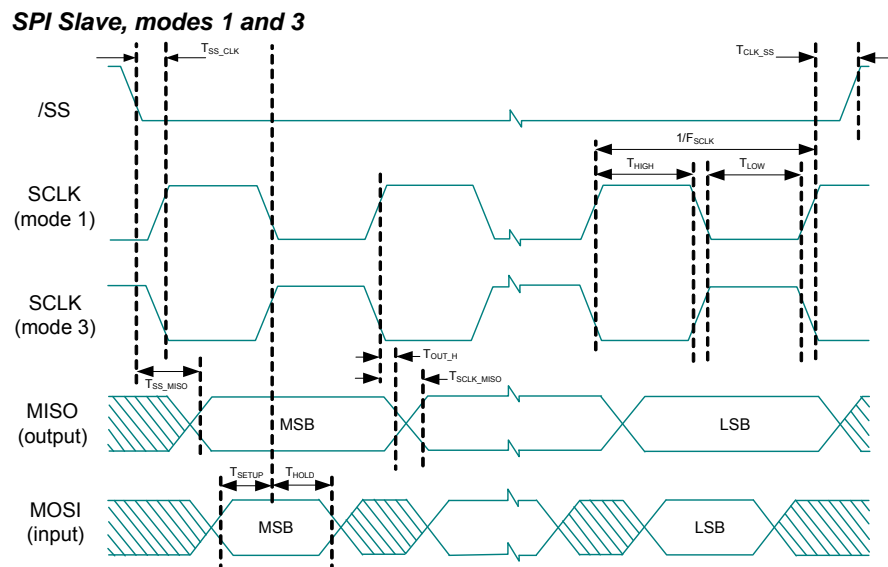
Figure 12. SPI Master Mode 0 and 2
SPI Master, modes 0 and 2

Figure 13. SPI Master Mode 1 and 3
SPI Master, modes 1 and 3


Table 31. SPI Slave AC Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
F_{SCLK}	SCLK clock frequency	—	—	—	4	MHz
t_{LOW}	SCLK low time	—	42	—	—	ns
t_{HIGH}	SCLK high time	—	42	—	—	ns
t_{SETUP}	MOSI to SCLK setup time	—	30	—	—	ns
t_{HOLD}	SCLK to MOSI hold time	—	50	—	—	ns
t_{SS_MISO}	SS high to MISO valid	—	—	—	153	ns
t_{SCLK_MISO}	SCLK to MISO valid	—	—	—	125	ns
t_{SS_HIGH}	SS high time	—	50	—	—	ns
t_{SS_CLK}	Time from SS low to first SCLK	—	$2/SCLK$	—	—	ns
t_{CLK_SS}	Time from last SCLK to SS high	—	$2/SCLK$	—	—	ns

Figure 14. SPI Slave Mode 0 and 2

Figure 15. SPI Slave Mode 1 and 3


Thermal Impedances

Table 32. Thermal Impedances per Package

Package	Typical θ_{JA} ^[57]
16-pin SOIC	95 °C/W
16-pin QFN	33 °C/W
24-pin QFN ^[58]	21 °C/W
32-pin QFN ^[58]	20 °C/W
48-pin QFN ^[58]	18 °C/W
30-ball WLCSP	54 °C/W

Capacitance on Crystal Pins

Table 33. Typical Package Capacitance on Crystal Pins

Package	Package Capacitance
32-Pin QFN	3.2 pF
48-Pin QFN	3.3 pF

Solder Reflow Peak Temperature

Table 34 shows the solder reflow temperature limits that must not be exceeded.

Table 34. Solder Reflow Peak Temperature

Package	Maximum Peak Temperature (T_C)	Maximum Time above $T_C - 5$ °C
16-pin SOIC	260 °C	30 seconds
16-pin QFN	260 °C	30 seconds
24-pin QFN	260 °C	30 seconds
32-pin QFN	260 °C	30 seconds
48-pin QFN	260 °C	30 seconds
30-ball WLCSP	260 °C	30 seconds

Notes

57. $T_J = T_A + \text{Power} \times \theta_{JA}$.

58. To achieve the thermal impedance specified for the QFN package, the center thermal pad must be soldered to the PCB ground plane.

Ordering Information

Table 35 lists the CY8C20x37/47/67/S PSoC devices' key package features and ordering codes.

Table 35. PSoC Device Key Features and Ordering Information

Ordering Code	Package	Flash (Bytes)	SRAM (Bytes)	CapSense Sensors	Digital I/O Pins	Analog Inputs ^[59]	XRES Pin	ADC
CY8C20237-24SXI	16-pin SOIC	8 K	1 K	10	13	13	Yes	Yes
CY8C20247S-24SXI	16-pin SOIC	16 K	2 K	10	13	13	Yes	Yes
CY8C20237-24LKXI	16-pin QFN	8 K	1 K	10	13	13	Yes	Yes
CY8C20237-24LKXIT	16-pin QFN (Tape and Reel)	8 K	1 K	10	13	13	Yes	Yes
CY8C20247S-24LKXI	16-pin QFN	16 K	2 K	10	13	13	Yes	Yes
CY8C20247S-24LKXIT	16-pin QFN (Tape and Reel)	16 K	2 K	10	13	13	Yes	Yes
CY8C20337-24LQXI	24-pin QFN	8 K	1 K	16	19	19	Yes	Yes
CY8C20337-24LQXIT	24-pin QFN (Tape and Reel)	8 K	1 K	16	19	19	Yes	Yes
CY8C20347-24LQXI	24-pin QFN	16 K	2 K	16	19	19	Yes	Yes
CY8C20347-24LQXIT	24-pin QFN (Tape and Reel)	16 K	2 K	16	19	19	Yes	Yes
CY8C20347S-24LQXI	24-pin QFN	16 K	2 K	16	19	19	Yes	Yes
CY8C20347S-24LQXIT	24-pin QFN (Tape and Reel)	16 K	2 K	16	19	19	Yes	Yes
CY8C20437-24LQXI	32-pin QFN	8 K	1 K	25	28	28	Yes	Yes
CY8C20437-24LQXIT	32-pin QFN (Tape and Reel)	8 K	1 K	25	28	28	Yes	Yes
CY8C20447-24LQXI	32-pin QFN	16 K	2 K	25	28	28	Yes	Yes
CY8C20447-24LQXIT	32-pin QFN (Tape and Reel)	16 K	2 K	25	28	28	Yes	Yes
CY8C20447S-24LQXI	32-pin QFN	16 K	2 K	25	28	28	Yes	Yes
CY8C20447S-24LQXIT	32-pin QFN (Tape and Reel)	16 K	2 K	25	28	28	Yes	Yes
CY8C20467-24LQXI	32-pin QFN	32 K	2 K	25	28	28	Yes	Yes
CY8C20467-24LQXIT	32-pin QFN (Tape and Reel)	32 K	2 K	25	28	28	Yes	Yes
CY8C20467S-24LQXI	32-pin QFN	32 K	2 K	25	28	28	Yes	Yes
CY8C20467S-24LQXIT	32-pin QFN (Tape and Reel)	32 K	2 K	25	28	28	Yes	Yes
CY8C20637-24LQXI	48-pin QFN	8 K	1 K	31	34	34	Yes	Yes
CY8C20637-24LQXIT	48-pin QFN (Tape and Reel)	8 K	1 K	31	34	34	Yes	Yes
CY8C20647-24LQXI	48-pin QFN	16 K	2 K	31	34	34	Yes	Yes
CY8C20647-24LQXIT	48-pin QFN (Tape and Reel)	16 K	2 K	31	34	34	Yes	Yes
CY8C20647S-24LQXI	48-pin QFN	16 K	2 K	31	34	34	Yes	Yes
CY8C20647S-24LQXIT	48-pin QFN (Tape and Reel)	16 K	2 K	31	34	34	Yes	Yes
CY8C20667-24LQXI	48-pin QFN	32 K	2 K	31	34	34	Yes	Yes
CY8C20667-24LQXIT	48-pin QFN (Tape and Reel)	32 K	2 K	31	34	34	Yes	Yes
CY8C20667S-24LQXI	48-pin QFN	32 K	2 K	31	34	34	Yes	Yes
CY8C20667S-24LQXIT	48-pin QFN (Tape and Reel)	32 K	2 K	31	34	34	Yes	Yes

Note

⁵⁹. Dual-function Digital I/O Pins also connect to the common analog mux.

Errata

This section describes the errata for the CY8C20xx7/S family. Details include errata trigger conditions, scope of impact, available workaround, and silicon revision applicability.

Contact your local Cypress Sales Representative if you have questions.

CY8C20xx7/S Qualification Status

Product Status: Production released.

CY8C20xx7/S Errata Summary

The following Errata items apply to the CY8C20xx7/S datasheet 001-69257.

1. DoubleTimer0 ISR

■Problem Definition

When programmable timer 0 is used in “one-shot” mode by setting bit 1 of register 0,B0h (PT0_CFG), and the timer interrupt is used to wake the device from sleep, the interrupt service routine (ISR) may be executed twice.

■Parameters Affected

No datasheet parameters are affected.

■Trigger Condition(S)

Triggered by enabling one-shot mode in the timer, and using the timer to wake from sleep mode.

■Scope of Impact

The ISR may be executed twice.

■Workaround

In the ISR, firmware should clear the one-shot bit with a statement such as “and reg[B0h], FDh”

■Fix Status

Will not be fixed

■Changes

None

2. Missed GPIO Interrupt

■Problem Definition

When in sleep mode, if a GPIO interrupt happens simultaneously with a Timer0 or Sleep Timer interrupt, the GPIO interrupt may be missed, and the corresponding GPIO ISR not run.

■Parameters Affected

No datasheet parameters are affected.

■Trigger Condition(S)

Triggered by enabling sleep mode, then having GPIO interrupt occur simultaneously with a Timer 0 or Sleep Timer interrupt.

■Scope of Impact

The GPIO interrupt service routine will not be run.

■Workaround

The system should be architected such that a missed GPIO interrupt may be detected. For example, if a GPIO is used to wake the system to perform some function, the system should detect if the function is not performed, and re-issue the GPIO interrupt. Alternatively, if a GPIO interrupt is required to wake the system, then firmware should disable the Sleep Timer and Timer0. Alternatively, the ISR's for Sleep Timer and Timer0 should manually check the state of the GPIO to determine if the host system has attempted to generate a GPIO interrupt.

■Fix Status

Will not be fixed

■Changes

None

Document History Page

Document Title: CY8C20xx7/S, 1.8 V CapSense® Controller with SmartSense™ Auto-tuning 31 Buttons, 6 Sliders, Proximity Sensors Document Number: 001-69257				
Revision	ECN	Orig. of Change	Submission Date	Description of Change
**	3276782	DST	06/27/2011	New silicon and document
*A	3327230	DST	07/28/2011	Changed 48-pin dimensions to 6 × 6 × 0.6 mm QFN Updated pins name in Table 3 on page 9 and removed USB column and updated dimensions for 48-pin parts in Table 35 on page 33 Updated Figure 20 on page 29 Removed ICE and Debugger sections. Removed CY3215 Development Kit and CY3280-20x66 UCC sections. Updated Ordering Information .
*B	3403111	YVA	10/12/2011	Moved status from Advance to Preliminary. Updated Ordering Information Removed the row named "48-Pin (6 × 6 mm) QFN (OCD)". Changed all 48-pin ordering code column from CY8C20XXX-24LTxx to CY8C20XXX-24LQxx. Updated 16-pin SOIC and 16-pin QFN package drawings.
*C	3473317	DST	12/23/2011	Updated Features . Updated Pinouts (Removed PSoC in captions of Figure 2 , Figure 3 , Figure 4 , Figure 6 , and Figure 7). Updated DC Chip-Level Specifications under Electrical Specifications (Updated typical value of I _{DD24} parameter from 3.32 mA to 2.88 mA, updated typical value of I _{DD12} parameter from 1.86 mA to 1.71 mA, updated typical value of I _{DD6} parameter from 1.13 mA to 1.16 mA, updated maximum value of I _{SB0} parameter from 0.50 µA to 1.1 µA, added I _{SB12C} parameter and its details). Updated DC GPIO Specifications under Electrical Specifications (Added the parameters namely V _{ILLVT3.3} , V _{IHLVT3.3} , V _{ILLVT5.5} , V _{IHLVT5.5} and their details in Table 10 , added the parameters namely V _{ILLVT2.5} , V _{IHLVT2.5} and their details in Table 11). Added the following sections namely DC I2C Specifications , Shield Driver DC Specifications , and DC IDAC Specifications under Electrical Specifications . Updated AC Chip-Level Specifications (Added the parameter namely t _{JIT_IMO} and its details). Updated Ordering Information (updated Table 35).
*D	3510277	YVA/DST	02/16/2012	Added CY8C20x37/37S/47/47S/67/67S part numbers and changed title to "1.8 V CapSense® Controller with SmartSense™ Auto-tuning 31 Buttons, 6 Sliders" Updated Features . Modified comparator blocks in Logic Block Diagram . Replaced SmartSense with SmartSense auto-tuning. Added CY8C20xx7S part numbers in Pin Definitions. Added footnote for Table 20 . Updated Table 21 and Table 22 and added Table 23 . Updated F _{32K1} min value. Updated data hold time min values. Updated CY8C206x7 part information in Table "Emulation and Programming Accessories". Updated Ordering Information .
*E	3539259	DST	03/01/2012	Changed Datasheet status from Preliminary to Final. Updated all Pinouts to include Driven Shield Output (optional) information. Updated Min value for V _{LPC} Table 15 . Updated Offset and Input range in Table 16 .

Document History Page *(continued)*

Document Title: CY8C20xx7/S, 1.8 V CapSense® Controller with SmartSense™ Auto-tuning 31 Buttons, 6 Sliders, Proximity Sensors Document Number: 001-69257				
Revision	ECN	Orig. of Change	Submission Date	Description of Change
*F	3645807	DST/BVI	07/03/2012	<p>Updated F_{SCLK} parameter in the Table 31, “SPI Slave AC Specifications,” on page 26</p> <p>Changed t_{OUT_HIGH} to t_{OUT_H} in Table 30, “SPI Master AC Specifications,” on page 25</p> <p>Updated Features section, “Programmable pin configurations” bullet:</p> <ul style="list-style-type: none"> ■ Included the following sub-bullet point - 5 mA source current on port 0 and 1 and 1 mA on port 2,3 and 4 ■ Changed the bullet point “High sink current of 25 mA for each GPIO” to “High sink current of 25 mA for each GPIO. Total 120 mA maximum sink current per chip” ■ Added “QuietZone™ Controller” bullet and updated “Low power CapSense® block with SmartSense™ auto-tuning” bullet. <p>Updated package diagrams 001-13937 to *D and 001-57280 to *C revisions.</p>
*G	3800055	DST	11/23/2012	<p>Changed document title.</p> <p>Part named changed from CY8C20xx7 to CY8C20xx7/S</p> <p>Table 20: Update to VIH2C to match Item #6 in K2 Si Errata document (001-75370)</p> <p>Updated package diagrams:</p> <p>51-85068 to *E 001-09116 to *G 001-13937 to *E 001-42168 to *E 001-57280 to *E</p>
*H	3881332	SRLI	02/04/2013	<p>Updated Features:</p> <p>Added Note “Please contact your nearest sales office for additional details.” and referred the same note in “24 Sensing Inputs – 30-pin WLCSP”.</p>
*I	3993458	DST	05/07/2013	<p>Updated Electrical Specifications (Updated DC GPIO Specifications (Updated heading of third column as “Port 0/1 per I/O (max)” for Table 13)).</p> <p>Updated Packaging Information: spec 001-09116 – Changed revision from *G to *H (Figure 17).</p> <p>Added Errata.</p>
*J	4081796	DST	07/31/2013	<p>Added Errata footnotes (Note 40, 41, 42, 43, 44).</p> <p>Updated already existing footnotes (Note 50, 51, 55) as Errata footnotes.</p> <p>Updated Electrical Specifications: Updated DC Chip-Level Specifications: Added Note 40, 41, 42, 43 and referred the same notes in I_{SB0}, I_{SB1}, I_{SB12C} parameters. Updated DC GPIO Specifications: Added Note 44 and referred the same note in description of V_{ILLVT3.3} parameter in Table 10. Updated DC I2C Specifications: Updated Note 50, 51 referred in Table 20. Updated AC I2C Specifications: Updated Note 55 referred in Table 29.</p> <p>Updated to new template.</p>

Document History Page *(continued)*

Document Title: CY8C20xx7/S, 1.8 V CapSense® Controller with SmartSense™ Auto-tuning 31 Buttons, 6 Sliders, Proximity Sensors Document Number: 001-69257				
Revision	ECN	Orig. of Change	Submission Date	Description of Change
*O	5122184	JFMD	02/02/2016	Updated Features : Removed Note "Please contact your nearest sales office for additional details." and its reference. Updated Ordering Information : Updated Table 35 : Updated part numbers.

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